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WHAT IS CLAIMED IS:

1. An apparatus for testing a liquid crystal display panel, comprising:

first and second testing bars corresponding to longer sides of a unit liquid crystal display panel testing for defect along a grinding edge of the unit liquid crystal display panel and measuring a distance between the longer sides of the unit liquid crystal display panel; and

third and fourth testing bars corresponding to shorter sides of a unit liquid crystal display panel testing for defect along a grinding edge of the unit liquid crystal display panel and measuring a distance between the shorter sides of the unit liquid crystal display panel.
2. The apparatus of claim 1, wherein the first to fourth testing bars include gauges.
3. The apparatus of claim 1, wherein the first and the second testing bars have lengths corresponding to the longer sides of the largest size unit liquid crystal

display panel model, and the third and the fourth testing bars have lengths corresponding to the shorter sides of the largest size unit liquid crystal display panel model.

4. The apparatus of claim 1, wherein the fourth testing bar has a length corresponding to the shorter sides of the smallest size unit liquid crystal display panel model.
5. The apparatus of claim 1, wherein the first and the third testing bars have a step shape.
6. The apparatus of claim 5, wherein at least one of the longer and shorter sides of the unit liquid crystal display panel engage with the step shape of one of the first and third testing bars.
7. The apparatus of claim 1, wherein the unit liquid crystal display panel includes a color filter substrate on a thin film transistor array substrate.

8. A method for testing a liquid crystal display panel,
comprising:

loading a unit liquid crystal display panel on a first
table including first, second, third and fourth testing
bars; and

measuring a distance between the longer sides of the unit
liquid crystal display panel while operating the first
and second testing bars and a distance between the
shorter sides of the unit liquid crystal display panel
while operating the third and fourth testing bars.
9. The method of claim 8, further comprising testing for
burr defect on at least one of the longer and shorter
sides of the unit liquid crystal display panel.
10. The method of claim 9, wherein the testing includes
testing whether or not the burr is remained on the longer
sides of the unit liquid crystal display panel using the
first and second testing bars.
11. The method of claim 9, wherein the testing includes

testing whether or not the burr is remained on the shorter sides of the unit liquid crystal display panel using the third and fourth testing bars.

12. The method of claim 9, wherein testing includes testing whether or not the burr is remained on the longer sides and on the shorter sides of the unit liquid crystal display panel using the first to fourth testing bars at the same time.
13. The method of claim 8, further comprising:

cutting a plurality of liquid crystal display panels into unit liquid crystal display panels prior to loading a unit liquid crystal display panel.
14. The method of claim 11, wherein testing at least one of the longer and shorter sides of the unit liquid crystal display panel includes checking a cut edge of the unit liquid crystal display panel.

15. The method of claim 14, wherein checking the cut edge is performed by touching at least one of the first, second, third and fourth testing bars to the cut edge of the unit liquid crystal display panel.
16. The method of claim 8, wherein the first and third testing bars have a step shape.
17. The method of claim 16, wherein at least one of the longer and shorter sides of the unit liquid crystal display panel engage with the step shape of at least one of the first and third testing bars.
18. The method of claim 8, wherein measuring a distance between the longer sides and a distance between the shorter sides is performed using a gauge.
19. The method of claim 8, wherein the unit liquid crystal display panel includes a color filter substrate on a thin film transistor array substrate.

20. A method for testing a liquid crystal display panel,
comprising:

loading a unit liquid crystal display panel on a first
table including first and second testing bars; and
testing for defect on opposite sides of the unit liquid
crystal display panel using the first and second testing
bars and at the same time measuring a distance of at
least one side of the unit liquid crystal display panel.

21. The method of claim 20, wherein one of the first and
second testing bars includes position sensors and wherein
the measuring comprises measuring the distance of the at
least one side of the unit liquid crystal display panel
using the position sensors.

22. The method of claim 20, wherein the first and second
testing bars include optical sensors and wherein the
measuring comprises measuring a distance of the at least
one side of the unit liquid crystal display panel using
the optical sensors.

23. The method of claim 22, wherein the optical sensors
includes a light source on one of the first and second

testing bars and a photo detector on the other of the first and second testing bars wherein the measuring comprises measuring the intensity of light received by the photo detector from the light source.